RoHS

COMPLIANT HALOGEN

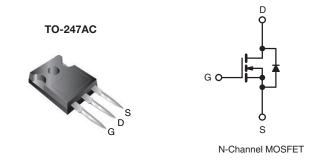
FREE



www.vishay.com

EF Series Power MOSFET with Fast Body Diode

PRODUCT SUMMARY				
V _{DS} (V) at T _J max.	650			
R _{DS(on)} max. at 25 °C (Ω)	V _{GS} = 10 V	0.098		
Q _g (Max.) (nC)	155			
Q _{gs} (nC)	22			
Q _{gd} (nC)	43			
Configuration	Single			



FEATURES

- Fast body diode MOSFET using E series technology
- Reduced t_{rr}, Q_{rr}, and I_{RRM}
- Low figure-of-merit (FOM): Ron x Qg
- Low input capacitance (Ciss)
- · Reduced switching and conduction losses
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

APPLICATIONS

- Telecommunications
 - Server and telecom power supplies
- Lighting
 - High-intensity discharge (HID)
 - Light emitting diodes (LEDs)
- Consumer and computing
 - ATX power supplies
- Industrial
 - Welding
 - Battery chargers
- Renewable energy
 - Solar (PV inverters)
- Switch mode power suppliers (SMPS)
- Applications using the following topologies
 - LLC
 - Phase shifted bridge (ZVS)
 - 3-level inverter
 - AC/DC bridge

ORDERING INFORMATION			
Package	TO-247AC		
Lead (Pb)-free and Halogen-free	SiHG33N60EF-GE3		

ABSOLUTE MAXIMUM RATINGS (_C = 25 °C, un	less otherwis	se noted)		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-Source Voltage			V _{DS}	600	
Gate-Source Voltage			.,	± 20	V
Gate-Source Voltage AC (f > 1 Hz)			V_{GS}	30	
Continuous Drain Current (T _J = 150 °C)	V at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	- I _D	33	
	V _{GS} at 10 V	T _C = 100 °C		21	Α
Pulsed Drain Current (Typical) ^a			I _{DM}	100	
Linear Derating Factor				2.2	W/°C
Single Pulse Avalanche Energy b			E _{AS}	691	mJ
Maximum Power Dissipation			P_{D}	278	W
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C
Drain-Source Voltage Slope	T _J =	T _J = 125 °C		70	1//20
Reverse Diode dV/dt ^d			dV/dt	20	V/ns
Soldering Recommendations (Peak Temperature	e) ^c for	for 10 s		300	°C

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 28.2 \,^{\circ}\text{mH}$, $R_q = 25 \,^{\circ}\Omega$, $I_{AS} = 7 \,^{\circ}\text{A}$.
- c. 1.6 mm from case.
- d. $I_{SD} \le I_D$, dI/dt = 100 A/ μ s, starting $T_J = 25$ °C.



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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	40	°C/W	
Maximum Junction-to-Case (Drain)	R_{thJC}	-	0.45	G/VV	

PARAMETER	SYMBOL	TES	TEST CONDITIONS			MAX.	UNIT
Static		_			L	L	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		600	_	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA	-	0.72	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} :	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V		-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		V _{DS} = 480 V, V _{GS} = 0 V V _{DS} = 480 V, V _{GS} = 0 V, T _J = 125 °C		-	1 500	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 16.5 A	-	0.085	0.098	Ω
Forward Transconductance a	9 _{fs}	V _{DS} :	$V_{DS} = 30 \text{ V}, I_D = 16.5 \text{ A}$		12	-	S
Dynamic						I.	•
Input Capacitance	C _{iss}	$V_{GS} = 0 V$,		-	3454	-	pF
Output Capacitance	C _{oss}		$V_{DS} = 100 \text{ V},$		154	-	
Reverse Transfer Capacitance	C _{rss}	f = 1 MHz		-	8	-	
Effective Output Capacitance, Energy Related ^b	C _{o(er)}	$V_{GS} = 0 \text{ V}, V_{DS} = 0 \text{ V to } 480 \text{ V}$		-	121	-	
Effective Output Capacitance, Time Related c	C _{o(tr)}			-	437	-	
Total Gate Charge	Qg		V _{GS} = 10 V I _D = 16.5 A, V _{DS} = 480 V		103	155	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V			22	-	
Gate-Drain Charge	Q_{gd}				43	-	
Turn-On Delay Time	$t_{d(on)}$			-	28	56	
Rise Time	t _r	$V_{DD} =$	V _{DD} = 480 V, I _D = 16.5 A		43	86	ns
Turn-Off Delay Time	$t_{d(off)}$	$R_g = 9.1 \Omega, V_{GS} = 10 V$		-	161	242	115
Fall Time	t _f			-	48	96	
Gate Input Resistance	R_g	f = 1 MHz, open drain		-	0.5	-	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	33	Α
Pulsed Diode Forward Current	I _{SM}			-	100	-	
Diode Forward Voltage	V_{SD}	T _J = 25 °C, I _S = 16.5 A, V _{GS} = 0 V		-	0.9	1.2	V
Reverse Recovery Time	t _{rr}	$T_J = 25 \text{ °C}, I_F = I_S = 16.5 \text{ A},$ $dI/dt = 100 \text{ A/µs}, V_R = 25 \text{ V}$		-	162	324	ns
Reverse Recovery Charge	Q _{rr}			-	1.0	2.0	μC
Reverse Recovery Current	I _{RRM}			-	13	-	Α

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .
- c. $C_{oss(tr)}$ is a fixed capacitance that gives the charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

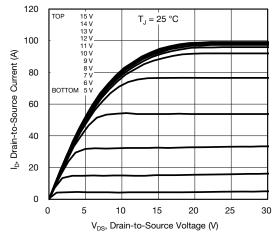


Fig. 1 - Typical Output Characteristics

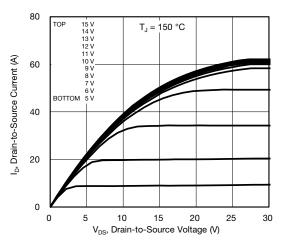


Fig. 2 - Typical Output Characteristics

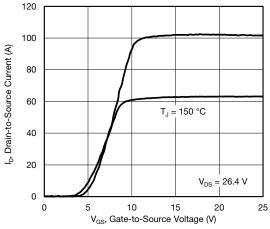


Fig. 3 - Typical Transfer Characteristics

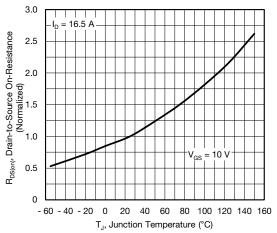


Fig. 4 - Normalized On-Resistance vs. Temperature

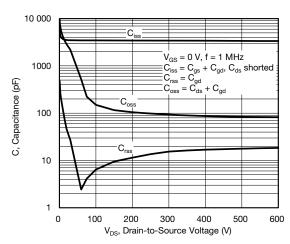


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

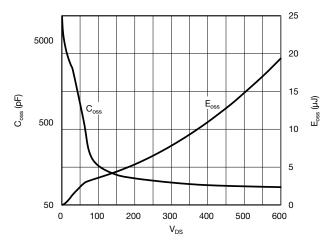


Fig. 6 - C_{oss} and E_{oss} vs. V_{DS}



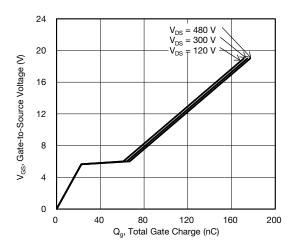


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

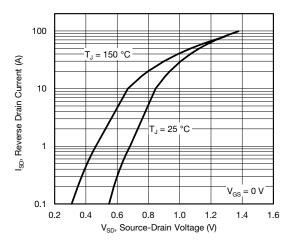


Fig. 8 - Typical Source-Drain Diode Forward Voltage

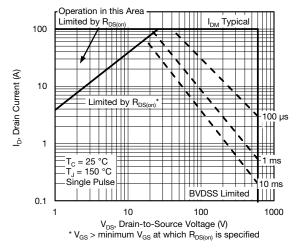


Fig. 9 - Maximum Safe Operating Area

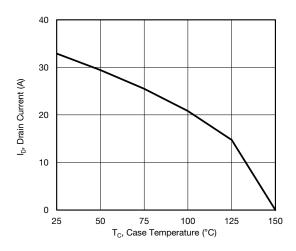


Fig. 10 - Maximum Drain Current vs. Case Temperature

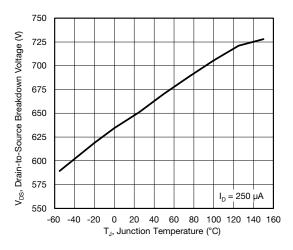
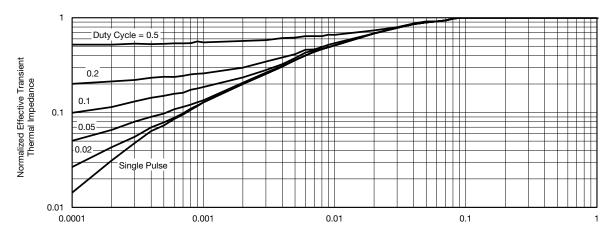


Fig. 11 - Typical Drain-to-Source Voltage vs. Temperature





Pulse Time (s)

Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

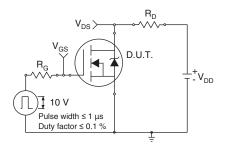


Fig. 13 - Switching Time Test Circuit

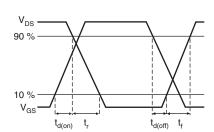


Fig. 14 - Switching Time Waveforms

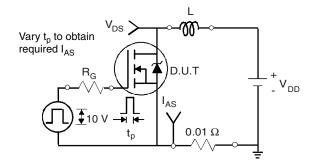


Fig. 15 - Unclamped Inductive Test Circuit

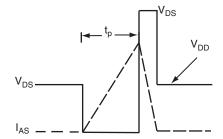


Fig. 16 - Unclamped Inductive Waveforms

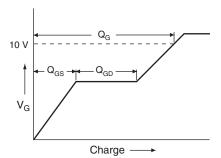


Fig. 17 - Basic Gate Charge Waveform

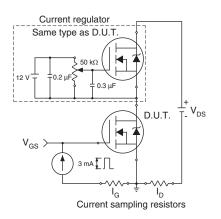
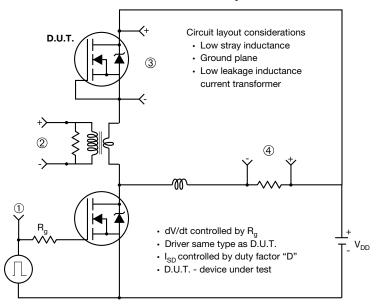


Fig. 18 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



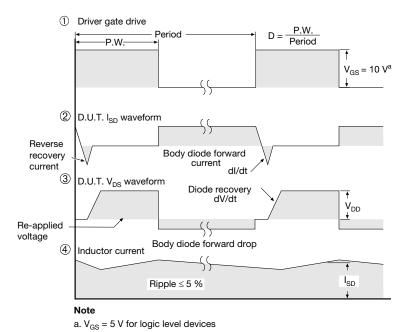


Fig. 19 - For N-Channel

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